

 Application/Control No.	Applicant(s)/Patent under Reexamination MURAKAWA ET AL.		
10/717,540			
Examiner	Art Unit		
David Lewis	2673		

	SEARCHED					
Class	Subclass	Date	Examiner			
345	87-100, 204, 211, 904	12/11/2005	DL			
324	527-530	12/11/2005	DL			
324	750	12/11/2005	DL			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH (INCLUDING SEAF)
	DATE	EXMR
EAST SEARCH keywords and subclass uspat and uspgpubs	12/11/2005	DL